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Application/Control No.	Applicant(s)/Patent under Reexamination
10/723,739	KUPĖEV ET AL.
Examiner	Art Unit
Phuoc Tran	2624

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Class	Subclass	Date	Examiner
382	173, 232, 236, 243, 250, 274	6/13/2007	РТ
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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